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CONFIGURATION SPACE COMPUTATION FOR POLYHEDRA WITH PLANAR MOTIONS

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Configuration space computation for polyhedra with planar motions

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Abstract

This report describes an algorithm that computes the configuration space of a polyhedron with planar motion relative to a fixed polyhedral obstacle. The algorithm decomposes the configuration space along the orientation axis into intervals of cross-sections with the same structure. It computes the angles where the structure changes. In each interval between two changes, it computes the (fixed) free-space structure from a representative cross-section then lifts the contact curves to construct an adjacency graph of contact patches.
1 Introduction

This report describes an algorithm that computes the configuration space of a polyhedral part with planar motion relative to a fixed polyhedral obstacle. The obstacle is specified in a global frame $(x, y, z)$. The part is specified in a local frame that is aligned with the global frame (same orientation) and whose origin lies in the $xy$ plane. The part translates parallel to the $xy$ plane and rotates around its $z$ axis. The configuration space is a cylinder whose coordinates are the position $(u, v)$ of the part frame in the $xy$ plane and the angle $\psi$ between the part $x$ axis and the global $x$ axis.

The algorithm constructs a boundary representation of free space comprised of contact patches. The patches are represented implicitly and parametrically. Each patch is bounded by a simple loop of boundary curves, which are represented parametrically. The boundary representation is represented as a contact graph whose nodes describe the patches and whose links describe the boundary curves of adjacent patches.

The contact graph is constructed by a method that I developed in prior work [3] and implemented for planar geometry [2]. The configuration space is decomposed along the $\psi$ axis into intervals of $uv$ cross-sections called slices. The slices within an interval have the same structure, but the structure can change at interval boundaries. In each interval, the algorithm constructs a representative slice, deduces its structure, and lifts this structure to the full configuration space to obtain the patches in the interval.

2 Criticality computation

The first stage of the algorithm computes the angles where the slice structure changes, which are called critical angles. Each slice is a planar subspace of configuration space in which the part translates at a fixed orientation. Its free space consists of planar regions and its contact space consists of loops of curve segments that bound these regions. Each segment is generated by a contact between a pair of part/obstacle features (vertices, edges, or faces). Feature pairs can also generate contact curves that lie wholly or partially in blocked space.

Two slices have the same structure when every component in each slice has a unique mate in the other slice with the same structure. Two components have the same structure when there exists a cyclic ordering of the second boundary for which every curve in each boundary has the same structure as the corresponding curve in the other boundary. Two curves have the same structure when they are generated by the same pair of part features.

The contact curves of polyhedra are linear. I require that the faces of the polyhedra be convex, which guarantees that each contact curve is a single line segment. A part with $n$ features and an obstacle with $m$ features generate $nm$ segments in the worst-case, but only $O(n)$ when both are convex. As $\psi$ changes, segments can enter and leave blocked space, but segments are never created or destroyed.

A necessary condition for a structure change at $\psi_0$ is that an endpoint of one contact segment
lies on another segment. If the condition does not hold, every pair of segments is either a positive
distance apart or intersects at a point in the interior of both segments (transversality). Both these
conditions persist in an interval around \( \psi_0 \) because the segments are continuous functions of \( \psi \).
The segments that lie in blocked space at \( \psi_0 \) are a positive distance from contact space, hence
stay in blocked space throughout the interval. The remaining segments form the contact space
throughout the interval. Each segment intersects two neighbors in its loop at \( \psi_0 \), hence intersects
the same two segments throughout the interval. These conditions mean that all the slices in the
interval have the same structure.

The necessary condition translates into an equation that can be solved for \( \psi \). Contact segment
endpoints have the form \( p = a + Rz b \) where \( a \) and \( b \) are vectors of length two and \( R \) is the
planar rotation operator. The conditions that endpoint \( p_3 \) lies on the segment \([p_1, p_2]\) are \((p_3 - p_1) \times (p_2 - p_1) = 0 \) and \( 0 \leq (p_3 - p_1) \cdot (p_2 - p_1) \leq (p_2 - p_1)^2 \). The equality simplifies to
\( k_1 \sin \psi + k_2 \cos \psi + k_3 = 0 \) where the \( k_i \) are functions of the \( a_i \) and \( b_i \) constants. This equation
yields at most two roots, for example using the substitution \( t = \tan(\psi/2) \). The roots that satisfy
the inequality are potential criticalities.

We now derive the endpoint expressions. There are three types of contacts: moving vertex/fixed
face, moving face/fixed vertex, and moving edge/fixed edge. The endpoints of the first two types
are configurations where the vertex lies on a boundary edge of the face. The endpoints of the third
type are configurations where a boundary vertex of one edge lies on the other edge. Hence, every
contact segment endpoint is a moving vertex/fixed edge contact or a moving edge/fixed vertex
contact.

In the vertex/edge case, the vertex has global coordinates \([u, v, 0] + Rz p\) with \( p = (p_x, p_y, p_z) \)
the part coordinates of the vertex and with \( R \) the operator that rotates around the z axis in \((x, y, z)\)
space. The edge endpoints are \( a \) and \( b \) in global coordinates and its direction vector is \( d = b - a \).
The vertex lies on the line generated by \( a \) and \( b \) when \([u, v, 0] + Rz p - a = kd\), which states that
\( p - a \) is colinear with \( d \). This is a system of three linear equations in \( u, v, k \). If \( d_z = 0 \) there is no
solution, otherwise \( k = (p_z - a_z)/d_z \) and
\[
\begin{bmatrix}
  u \\
  v 
\end{bmatrix} = \begin{bmatrix}
  a_x + k d_x \\
  a_y + k d_y
\end{bmatrix} - Rz \begin{bmatrix}
  v_x \\
  v_y
\end{bmatrix}.
\]
The solution lies on the segment \( ab \) (as opposed to the underlying line) when \( 0 \leq k \leq ||d|| \). The
edge/vertex analysis is the same, except that \( a \) and \( b \) vary, while \( v \) is fixed. The equations are
\( v - [u, v, 0] - Rz a = k R z d \) and the solutions are \( k = (p_z - a_z)/d_z \) and
\[
\begin{bmatrix}
  u \\
  v
\end{bmatrix} = \begin{bmatrix}
  v_x \\
  v_y
\end{bmatrix} - Rz \begin{bmatrix}
  a_x + k d_x \\
  a_y + k d_y
\end{bmatrix}.
\]

The algorithm enumerates all contact segment/contact endpoint triples, solves for \( \psi \), and returns the sorted results. Partial information is used to reduce computation. Here are a few examples. Two features cannot generate a contact when their \( z \) ranges are disjoint. A vertex/face contact
cannot occur if an edge incident to the vertex has negative inner product with the outward face normal. A segment endpoint cannot fall on a segment if the local geometry intersects. Criticalities that pass these quick tests are tested for part overlap via a naive polyhedron intersection algorithm.

3 Contact graph construction

After the criticalities are computed, the contact graph is constructed. The patches are constructed independently in each interval \((lb, ub)\) between adjacent criticalities. The midpoint slice, \(\psi = 0.5 \cdot (lb + ub)\), is constructed by my planar algorithm [4], which generates all contact curves, computes their arrangement by a line sweep, and returns the connected components where the parts do not overlap. The only modification is the module that constructs the contact segments. The construction is straightforward linear algebra and resembles Latombe’s treatment [1].

The construction is straightforward linear algebra and resembles Latombe’s treatment [1].

The midpoint slice yields the patch structure in \((lb, ub)\). Each contact segment lifts to a patch with the same pair of features in contact. The patch contact functions (implicit and parametric) are derived from the feature pair following Latombe. Segment adjacency transfers to the patches. The boundary curve between adjacent patches is computed from the parametric contact functions of the adjacent patches. The given \(\psi\) value is substituted into the functions to obtain two linear equations in \(u\) and \(v\) that are solved for the boundary curve point \((u, v, \psi)\).

Every patch also has a lower boundary segment in the \(lb\) plane and an upper boundary segment in the \(ub\) plane. A patch can have zero, one, or more upper neighbors along an upper boundary segment and likewise below. These adjacencies are computed after all the patches are constructed.

4 Implementation

I have implemented the configuration space computation algorithm in Lisp and have validated it on moderate size examples. For example, a part with 26 features and an obstacle with 128 features takes between 100 and 200 milliseconds on a 933 MHz Pentium 3 running Linux. A C implementation would probably take 10 to 20 milliseconds based on my extensive porting experience.

References

